

SPURIOUS RADIATED EMISSIONS

DATA

FOR

QUALCOMM, INC. 10300 Campus Point Drive San Diego, CA 92121

Prepared by

TÜV PRODUCT SERVICE 10040 Mesa Rim Road San Diego, CA 92121-2912

> Page 1 of 15 Rev.No 1.0

Report No. S8592-03



Measurement Requirements (CFR 47 Part 2, Paragraph 2.993 & Part 24, Paragraph 24.238)

The measurements which follow were performed by TÜV Product Service. To the best of my knowledge these tests were conducted in accordance with the procedures outlined in Part 2 of the Commission's Rules and Regulations. The data presented below demonstrates compliance with the appropriate technical standards.

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Floyd R. Fleury EMC Manager, EIC



Emissions Test Conditions: SPURIOUS RADIATED EMISSIONS

The Spurious Radiated Emissions measurements were performed using the following equipment:

Test Equipment Used : Model No.		Description	Manufacturer	Serial No.	Cal Date
8566B	720/721	Spectrum Analyzer & Display	Hewlett Packard	2115A00842	2 02/18/99
				2112A0218	5
AA-190-10.00.0	655	Cable	United Microwave		N/A
			Prod.		
AA-190-06.00.0	657	Cable	United Microwave		N/A
			Prod.		
AA-190-30.00.0	733	Cable	United Microwave		N/A
			Prod.		
AMF-5D-010180-35-10P	719	Pre-amplifier	Miteq	549460	04/07/99
3115	453	Double Ridge Antenna	EMCO	9412-4364	03/10/99
F4777		High Pass Filter	Qualcomm		N/A
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Remarks:					

Page 3 of 15 Rev.No 1.0



REPORT No	S8592 TESTED BY:	DM SPEC: FCC Part 2, Para. 2.993 & Part 24, 24.238
CUSTOMER	: Qualcomm, Inc.	TEST DIST: 3 Meters
EUT:	Model QCT-7200	TEST SITE: 3
EUT MODE:	Transmit, CDMA	BICONICAL: N/A
DATE:	15-Dec-98	LOG PERIODIC: N/A
NOTES:	Wireless local loop phone. RBW and VBW = 1 MHz. With vertical antenna. Cha All harmonics below noise f	

FREQ (MHz)	VERT (dB pk		HORIZ((dB pk		CORRECTION FACTOR (dB/m)	MAX L (dBu) pk	EVEL V/m) av	SPEC (dBu\ pk	LIMIT //m) av	MAR (di pk		EUT Rotatio	Antenna Helght	
1851	91.7		79		31.5	123.2		•		-				
3702	6.7		6.7		41.1	47.8		84.4		-36.6	<u> </u>			
5554	7.5		7.5		48.3	55.8		84.4		-28.6	· · ·			
7404	13		13		48.3	61.3		84.4		-23.1				
9256	13.4		13.4		52.8	66.2		84.4		-18.2				
11107	13.4		13.4		54.7	68.1		84.4		-16.3				
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	CORRECTION MAX LEVEL SPEC LIMIT MARGIN	Ante Hel Rot
All harmonics below noise flo	oor.	
With panel antenna. Channe		
RBW and VBW = 1 MHz.		
Wireless local loop phone.	OTHER: 453	
15-Dec-98	LOG PERIODIC: N/A	
Transmit, CDMA	BICONICAL: N/A	
Model QCT-7200	TEST SITE: 3	
: Qualcomm, Inc.	TEST DIST: 3 Meters	
: \$8592 TESTED BY: C	DM SPEC: FCC Part 2, Para. 2.993 & Part 2	24, 24.238
: \$859	2 TESTED BY:	2 TESTED BY: DM SPEC: FCC Part 2, Para. 2.993 & Part 3

FREQ (MHz)	VER1 (d8 pk		HORIZ((dB) pk	ONTAL uv) av	CORRECTION FACTOR (dB/m)	MAX LI (dBu\ pk	EVEL //m) av	SPEC (dBu\ pk	LIMIT V/m) av	MAR (di pk		EUT Rotatio	Antenna Height	
1851	94.7		80.8		31.5	126.2		-		-				
3702	6.7		6.7		41.1	47.8		84.4		-36.6				
5554	7.5		7.5		45.9	53.4		84.4		-31		1		
7404	13		13		48.3	61.3		84.4		-23.1				
9256	13.4		13.4		52.8	66.2		84.4		-18.2				
11107	13.4		13.4		54.7	68.1		84.4		-16.3				
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REPORT No:	S8592 TESTED BY: I	DM SPEC: FCC Part 2, Para. 2.993 & Part 24, 24.238
CUSTOMER:	Qualcomm, Inc.	TEST DIST: 3 Meters
EUT:	Model QCT-7200	TEST SITE: 3
EUT MODE:	Transmit, CDMA	BICONICAL: N/A
DATE:	15-Dec-98	LOG PERIODIC: N/A
NOTES:	Wireless local loop phone. RBW and VBW = 1 MHz.	OTHER: 453

With vertical antenna. Channel 600. All harmonics below noise floor.

FREQ (MHz)	VER1 (dB pk		HORIZ((dB pk	ONTAL uv) av	CORRECTION FACTOR (dB/m)	MAX Li (dBu\ pk	EVEL //m) av	SPEC (dBu\ pk	LIMIT V/m) av	MAR (di pk		EUT Rotatio	Antenna Height	
1880	91.4	· · · · · · · · · · · · · · · · · · ·	75.9		31.5	122.9		-						
3760	6.7		6.7		41.3	48.0		84.4		-36.4				
5640	7.5		7.5		45.9	53.4		84.4		-31		1		
7520	13		13		49.4	62.4		84.4		-22				
9400	13.4		13.4		52.9	66.3		84.4		-18.1				
11280	13.4		13.4		54.8	68.2		84.4		-16,2				
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REPORT No:	\$8592	TESTED BY: D	M SPEC:	FCC Part 2, Para. 2.993 & Part 24, 24.238
CUSTOMER:	Qualcomm,	Inc.	TEST DIST:	3 Meters
EUT:	Model QCT-	7200	TEST SITE:	3
EUT MODE:	Transmit, Cl	АМС	BICONICAL:	N/A
DATE:	15-Dec-98		LOG PERIODIC:	N/A
NOTES:		al loop phone.	OTHER:	453
	RBW and V	BW = 1 MHz.		

With panel antenna. Channel 600. All harmonics below noise floor.

FREQ (MHz)		TICAL uv) av	HORIZO (dB pk		CORRECTION FACTOR (dB/m)	(d8u\ pk	EVEL //m) av	SPEC (dBu\ pk	LIMIT //m) av	MAR (di pk		EUT Rotatio	Antenna Height	
1880	94.7		80.5		31.5	126.2		-		-				
3760	6.7		6.7		41.3	48.0		84.4		-36.4				
5640	7.5		7.5		45.9	53.4		84.4		-31				
7520	13		13		49.4	62.4		84.4		-22				
9400	13.4		13.4		52.9	66.3		84.4		-18.1	[·			
11280	13.4		13.4		54.8	68.2		84.4		-16.2		T		
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REPORT No:	S8592	TESTED BY: DM	SPEC	FCC Part 2, Para. 2.993 & Part 24, Para. 24.238
CUSTOMER:	Qualcomm, I	nc.	TEST DIST	3 Meters
EUT:	Model QCT-	7200	TEST SITE	3

EUT MODE: Transmit, CDMA BICONICAL: N/A

DATE: 15-Dec-98 LOG PERIODIC: N/A

	av	pk	uv) av	FACTOR (dB/m)	(dBu\ pk	//m) av	SPEC I (dBu\ pk	//m) av	MAR (di pk		EUT Rotatio	Antenna Helght	
91		74.6		31.5	122.5		-		-				·
6.7		6.7		41.1	47.8		84,4		-36.6				
7.5		7.5		48.3	55.8		84.4						
		13		48.3	61.3		84.4						
13.4		13.4		52.8	66.2		84.4		-18.2				
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	6.7 7.5 13	6.7 7.5 13	6.7 6.7 7.5 7.5 13 13	6.7 6.7 7.5 7.5 13 13	6.7 6.7 41.1 7.5 7.5 48.3 13 13 48.3	6.7 6.7 41.1 47.8 7.5 7.5 48.3 55.8 13 13 48.3 61.3	6.7 6.7 41.1 47.8 7.5 7.5 48.3 55.8 13 13 48.3 61.3	6.7 6.7 41.1 47.8 84.4 7.5 7.5 48.3 55.8 84.4 13 13 48.3 61.3 84.4	6.7 6.7 41.1 47.8 84.4 7.5 7.5 48.3 55.8 84.4 13 13 48.3 61.3 84.4	6.7 6.7 41.1 47.8 84.4 -36.6 7.5 7.5 48.3 55.8 84.4 -28.6 13 13 48.3 61.3 84.4 -23.1	6.7 6.7 41.1 47.8 84.4 -36.6 7.5 7.5 48.3 55.8 84.4 -28.6 13 13 48.3 61.3 84.4 -28.6	6.7 6.7 41.1 47.8 84.4 -36.6 7.5 7.5 48.3 55.8 84.4 -28.6 13 13 48.3 61.3 84.4 -28.6	6.7 6.7 41.1 47.8 84.4 -36.6 1 7.5 7.5 48.3 55.8 84.4 -28.6 1 13 13 48.3 61.3 84.4 -23.1 1

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REPORT No:	S8592	TESTED BY: DM	SPEC: FCC Part 2, Para. 2.993 & Part 24, Para. 24.238
CUSTOMER: C	Jualcomm	Inc.	TEST DIST: 3 Meters

CUSTOMER:	Qualcomm, Inc.	TEST DIST: 3 Meters
EUT:	Model QCT-7200	TEST SITE: 3
EUT MODE:	Transmit, CDMA	BICONICAL: N/A
DATE:	15-Dec-98	LOG PERIODIC: N/A
NOTES.	Mississe level loop phone	

NOTES:	Wireless local loop phone.	OTHER: 453
	RBW and VBW = 1 MHz.	
	With panel antenna. Channel 1175.	
	All harmonics below noise floor.	

FREQ (MHz)	VER1 (dB pk		HORIZO (dB pk		CORRECTION FACTOR (dB/m)	MAX L (dBu\ pk	EVEL //m) av	SPEC (dBu\ pk		MAR (di pk		EUT Rotatio	Antenna Height	
1908.75	94.5		81.2		31.5	126.0		-		-				
3817.5	6.7		6.7		41.1	47.8		84.4		-36.6				
5726.3	7.5		7.5		48.3	55.8		84.4		-28.6				
7635	13		13		48.3	61.3		84.4		-23.1				
9543.8	13.4		13.4		52.8	66.2		84.4		-18.2				
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Testing Facilities

Certificates of Approval

Page 10 of 15 Rev.No 1.0 Report No. S8592-03

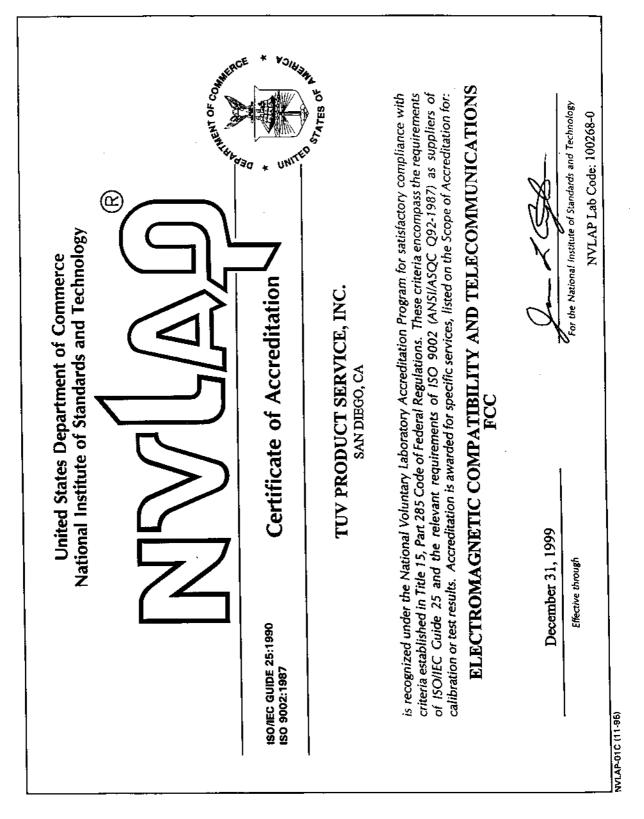
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of Standard	National Institute National Voluntary ds and Technology Accreditation Program
ISO/IEC GUI ISO 9002:11	IDE 25:1990 Scope of Accreditation
	Page: 1 of 1 IAGNETIC COMPATIBILITY NVLAP LAB CODE 100268-0
AND TELEC	COMMUNICATIONS TUV PRODUCT SERVICE, INC. 10040 Mesa Rim Road San Diego, CA 92121-1034 Mr. Floyd R. Fleury Phone: 619-546-3999 Fax: 619-546-0364
NVLAP Code	Designation / Description
International S	Special Committee on Radio Interference (CISPR) Methods
12/CIS22	IEC/CISPR 22:1993: Limits and methods of measurement of radio disturbance characteristics of information technology equipment
Federal Comn	nunications Commission (FCC) Methods
12/F01	FCC Method - 47 CFR Part 15 - Digital Devices
12/F01a	Conducted Emissions, Power Lines, 450 KHz to 30 MHz
12/F01b	Radiated Emissions
Australian Sta	andards referred to by clauses in AUSTEL Technical Standards
12/T51	AS/NZS 3548: Electromagnetic Interference - Limits and Methods of Measurement of Information Technology Equipment
	·
	December 31, 1999 Effective through For the National Institute of Standards and Technology

Page 11 of 15 Rev.No 1.0 Report No. S8592-03









UNITED STATES DEPARTMENT OF COMMERCE National Institute of Standards and Technology Gaithersburg, Maryland 20899-

December 1, 1998

Dear Mr. Fleury:

Mr. Floyd R. Fleury TUV Product Service, Inc. 10040 Mesa Rim Road San Diego, CA 92121-1034

NVLAP Lab Code: 100268-0

I am pleased to inform you that continuing accreditation for specific test methods in Electromagnetic Compatibility & Telecommunications, FCC is granted to your organization under the National Voluntary Laboratory Accreditation Program (NVLAP). This accreditation is effective until December 31, 1999, provided that your organization continues to comply with accreditation requirements contained in the NVLAP Procedures.

Your Certificate of Accreditation is enclosed along with a statement of your Scope of Accreditation. You may reproduce these documents in their entirety and announce your organization's accreditation status using the NVLAP logo in business publications, the trade press, and other business-oriented literature. Accreditation does not relieve your organization from observing and complying with any applicable existing laws and/or regulations.

We are pleased to have you participate in NVLAP and look forward to your continued association with this program. If you have any questions concerning your NVLAP accreditation, please direct them to Jon Crickenberger, Sr. Program Manager, Laboratory Accreditation Program, National Institute of Standards and Technology, 100 Bureau Dr. Stop 2140, Gaithersburg, MD 20899-2140; (301) 975-4016.

Sincerely,

James L. Cigler, Chief Laboratory Accreditation Program

Enclosure(s)



Page 13 of 15 Rev.No 1.0

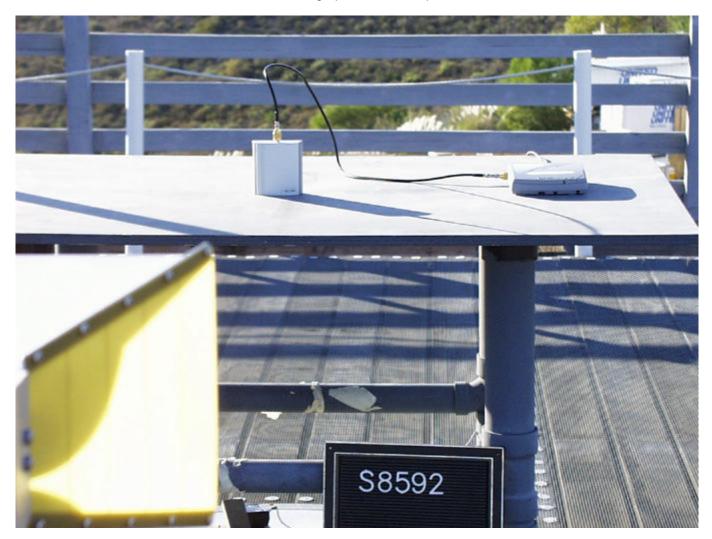


Photograph of Test Setup S8592 DM

> Page 14 of 15 Rev.No 1.0



Photograph of Test Setup



Page 15 of 15 Rev.No 1.0